

Notice of References Cited	Application/Control No. 10/731,610	Applicant(s)/Patent Under Reexamination KWON ET AL.	
	Examiner Khanh V. Nguyen	Art Unit 2817	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,657,494	12-2003	Twomey, Gerald J.	330/254
	B	US-6,710,659	03-2004	Teramoto et al.	330/254
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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